



# P-Channel 8 V (D-S) MOSFET

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)				
- 8	0.064 at V <sub>GS</sub> = - 4.5 V	- 4.6					
	0.076 at V <sub>GS</sub> = - 2.5 V	- 4.2	6.9 nC				
	0.115 at V <sub>GS</sub> = - 1.5 V	- 3.4	0.9110				
	0.180 at V <sub>GS</sub> = - 1.2 V	- 1.2					

#### **FEATURES**

 Halogen-free According to IEC 61249-2-21 Definition



- Ultra-Small 1 mm x 1 mm Maximum Outline
- Ultra-Thin 0.548 mm Maximum Height
- Compliant to RoHS Directive 2002/95/EC

# Pb-free BoHS

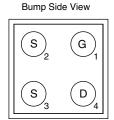
ROHS COMPLIANT HALOGEN FREE

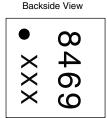
#### **APPLICATIONS**

- Load Switches, Battery Switches and Charger Switches in Portable Device Applications
- · Load Switch for 1.2 V Power Line

## In Pol

MICRO FOOT

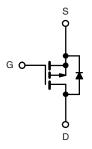




Device Marking: 8469

xxx = Date/Lot Traceability Code

Ordering Information: Si8469DB-T2-E1 (Lead (Pb)-free and Halogen-free)



P-Channel MOSFET

Parameter		Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	- 8	V	
Gate-Source Voltage		V <sub>GS</sub> ± 5		v
	T <sub>A</sub> = 25 °C		- 4.6 <sup>a</sup>	
Continuous Proin Current (T. – 150 °C)	T <sub>A</sub> = 70 °C		- 3.7 <sup>a</sup>	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 3.6 <sup>b</sup>	
	T <sub>A</sub> = 70 °C		- 2.8 <sup>b</sup>	А
Pulsed Drain Current		I <sub>DM</sub> - 15		
	T <sub>A</sub> = 25 °C		- 1.4 <sup>a</sup>	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 0.6 <sup>b</sup>	
	T <sub>A</sub> = 25 °C		1.8 <sup>a</sup>	
Mariana Paran Dissipation	T <sub>A</sub> = 70 °C	D	1.1 <sup>a</sup>	10/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.78 <sup>b</sup>	W
	T <sub>A</sub> = 70 °C		0.5 <sup>b</sup>	
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		
Dooks as Deflow Conditions	VPR	-	260	°C
Package Reflow Conditions <sup>c</sup>	IR/Convection		260	

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board with full copper, t = 10 s.
- b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 10 s.
- c. Refer to IPC/JEDEC (J-STD-020C), no manual or hand soldering.
- d. In this document, any reference to case represents the body of the MICRO FOOT device and foot is the bump.
- e. Based on  $T_A = 25$  °C.



THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>a, b</sup>	t = 10 s	D	55	70	°C/W		
Maximum Junction-to-Ambient <sup>c, d</sup>	t = 10 s	R <sub>thJA</sub>	125	160	- C/VV		

#### Notes:

- a. Surface mounted on 1" x 1" FR4 board with full copper.
- b. Maximum under steady state conditions is 100 °C/W.
- c. Surface mounted on 1" x 1" FR4 board with minimum copper.
- d. Maximum under steady state conditions is 190  $^{\circ}\text{C/W}.$

Parameter	Symbol	Min.	Тур.	Max.	Unit	
Static		Test Conditions				
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 8			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			- 6.4		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		2.4		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.35		- 0.8	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$			± 100	nA
7 0 1 1/1 5 1 0 1		V <sub>DS</sub> = -8 V, V <sub>GS</sub> = 0 V			- 1	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 8 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C			- 10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 10			Α
	(3)	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 1.5 A	0.052 0.064		0.064	
Durin Occurs On Olate Basistana 8		V <sub>GS</sub> = - 2.5 V, I <sub>D</sub> = - 1 A		0.062	0.076	Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 1.5 V, I <sub>D</sub> = - 0.3 A		0.085	0.115	
		V <sub>GS</sub> = - 1.2 V, I <sub>D</sub> = - 0.3 A		0.110	0.180	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 4 V, I <sub>D</sub> = - 1.5 A		12		S
Dynamic <sup>b</sup>		-				I.
Input Capacitance	C <sub>iss</sub>			900		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -4 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		315		
Reverse Transfer Capacitance	C <sub>rss</sub>			260		
Total Gate Charge	Qq			11	17	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -4 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1.5 \text{ A}$		0.85		
Gate-Drain Charge	$Q_{gd}$			2.5		
Gate Resistance	$R_{g}$	V <sub>GS</sub> = - 0.1 V, f = 1 MHz		6		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			15	30	
Rise Time	t <sub>r</sub>	$V_{DD} = -4 \text{ V}, R_{L} = 2.7 \Omega$		22	45	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -1.5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		35	70	
Fall Time	t <sub>f</sub>			17	35	
<b>Drain-Source Body Diode Characteris</b>	tics					
Continuous Source-Drain Diode Current I <sub>S</sub>		T <sub>A</sub> = 25 °C			- 1.5	А
Pulse Diode Forward Current	I <sub>SM</sub>				- 15	A
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 1.5 A, V <sub>GS</sub> = 0 V		- 0.9	- 1.3	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			25	50	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	_ 1 5 A dl/dt = 100 A/up T		10	20	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -1.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		10		ns
Reverse Recovery Rise Time	t <sub>b</sub>	1		15		

#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

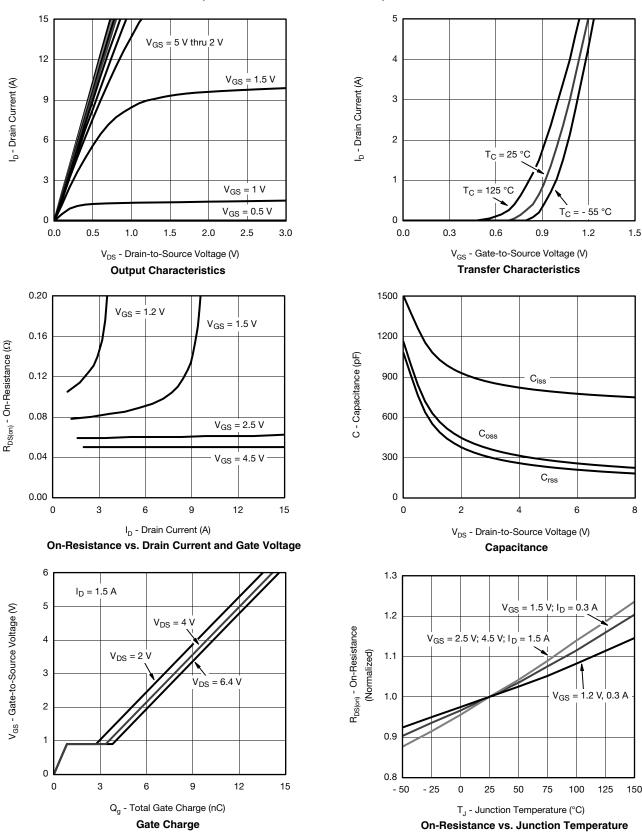
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



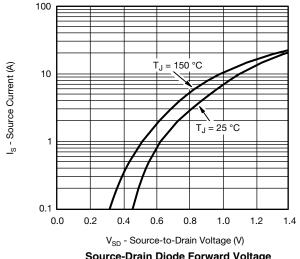


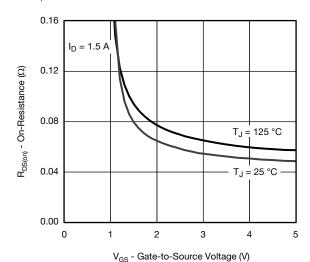


## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



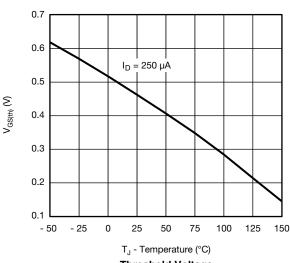
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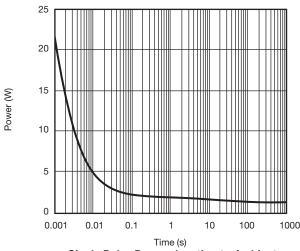




Source-Drain Diode Forward Voltage

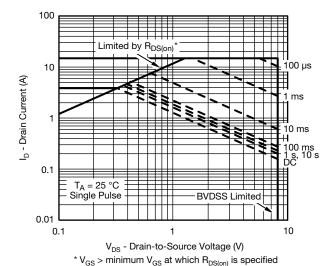






**Threshold Voltage** 

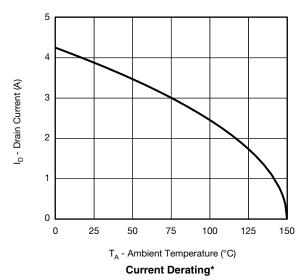
Single Pulse Power, Junction-to-Ambient

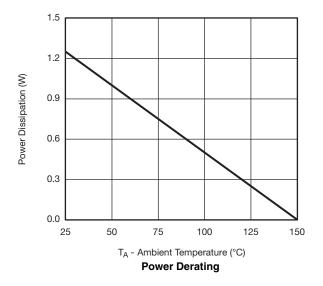






## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





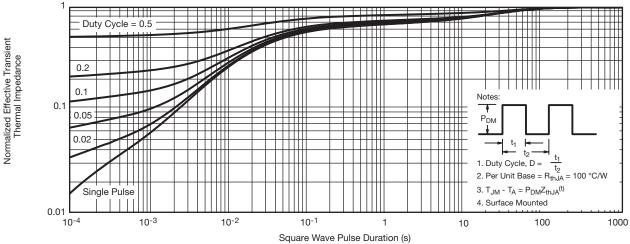
Note:

When mounted on 1" x 1" FR4 with full copper.

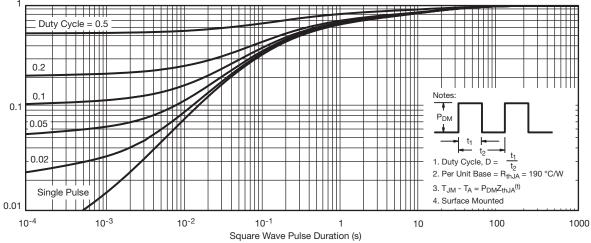
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient (1" x 1" FR4 Board with Full Copper)



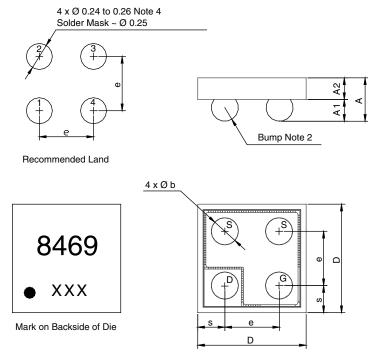
Normalized Thermal Transient Impedance, Junction-to-Ambient (1" x 1" FR4 Board with Minimum Copper)

Normalized Effective Transient Thermal Impedance



#### **PACKAGE OUTLINE**

### MICRO FOOT: 4-BUMP (2 x 2, 0.5 mm PITCH)



Notes (Unless otherwise specified):

- 1. All dimensions are in millimeters.
- 2. Four (4) solder bumps are lead (Pb)-free 95.5Sn/3.8Ag/0.7Cu with diameter  $\varnothing$  0.30 mm to 0.32 mm.
- 3. Backside surface is coated with a Ti/Ni/Ag layer.
- 4. Non-solder mask defined copper landing pad.
- 5. is location of pin 1.

Dim.	Millimeters <sup>a</sup>			Inches			
	Min.	Nom.	Max.	Min.	Nom.	Max.	
Α	0.462	0.505	0.548	0.0181	0.0198	0.0215	
A <sub>1</sub>	0.220	0.250	0.280	0.0086	0.0098	0.0110	
A <sub>2</sub>	0.242	0.255	0.268	0.0095	0.0100	0.0105	
b	0.300	0.310	0.320	0.0118	0.0122	0.0126	
е	0.500			0.0197			
s	0.230	0.250	0.270	0.0090	0.0098	0.0106	
D	0.920	0.960	1.000	0.0362	0.0378	0.0394	

#### Notes

 $\ensuremath{\text{a.}}$  Use millimeters as the primary measurement.

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